

Notice of References Cited

Application/Control No.

10/524,454

Applicant(s)/Patent Under
Reexamination
DALSTRA, JOOP

Examiner

KEITH T. AZIZ

Art Unit

4122

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,198,102	03-2001	Shepherd, William T.	250/340
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Rantanen et al., "Use of the Near-Infrared Reflectance Method for Measurement of Moisture content during granulation", Pharmaceutical Development and Technology, Issue 5, 2000, pp. 209-217			
	V	Bur et al., "Volume Viscoelastic Relaxation in a glass forming polymer during injection molding", Annual Technical Conference of the Society of Plastics Engineers, 1996			
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.